

Erbium nickel trisilicide, ErNiSi_3

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Key indicators

Single-crystal X-ray study
 $T = 295 \text{ K}$
Mean $\sigma(\text{Ni-Si}) = 0.001 \text{ \AA}$
 R factor = 0.016
 wR factor = 0.040
Data-to-parameter ratio = 16.4

For details of how these key indicators were automatically derived from the article, see <http://journals.iucr.org/e>.

Single crystals of ErNiSi_3 were synthesized from the corresponding elements by arc melting. The ternary intermetallic compound crystallizes in the orthorhombic space group $Cmmm$ and adopts the SmNiGe_3 structure type, with all atoms in special positions of site symmetry $m2m$.

Comment

Ternary intermetallics of rare-earth metals with the general formula $RETX_3$ (where RE is a rare earth metal, T is a transition metal and X is a p -block element) crystallize mostly in eight structure types, viz. orthorhombic ScNiSi_3 , SmNiGe_3 and YNiAl_3 , tetragonal BaNiSn_3 , cubic CaTiO_3 , LaRuSn_3 , TmRuGa_3 and CeRuGe_3 (Parthé *et al.*, 1993–1994).

The $RETX_3$ phases have received special attention for their interesting magnetic and electric properties. An accurate determination of the crystal structure for phases of this

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In memory of Professor Dr
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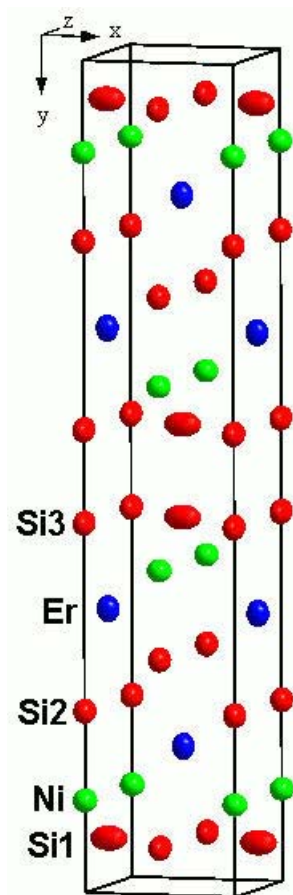


Figure 1
Clinographic projection of the ErNiSi_3 unit-cell contents, with displacement ellipsoids drawn at the 95% probability level.

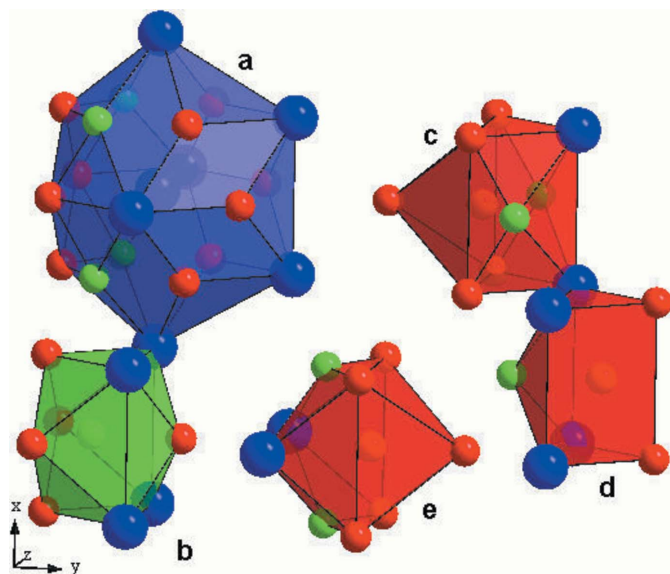


Figure 2
Coordination polyhedra around (a) the Er atom, (b) the Ni atom, and (c–e) the Si atoms. Er atoms are blue, Ni atoms are green and Si atoms are red.

composition is a basic requirement for the better understanding of their physical properties. The existence of the phase ErNiSi_3 was first reported by Gorelenko *et al.* (1977), who, on the basis of X-ray powder diffraction data, established that the crystal structure adopted the orthorhombic ScNiSi_3 structure type. In view of the closeness of the structure types ScNiSi_3 (space group $Amm2$) and SmNiGe_3 (space group $Cmmm$), it was necessary to determine precisely the structure type for ErNiSi_3 on the basis of single-crystal diffraction data, and we present these results here.

In contrast to the previous examination (Gorelenko *et al.*, 1977), ErNiSi_3 does not crystallize in the ScNiSi_3 structure type, but adopts the SmNiGe_3 structure type (Bodak *et al.*, 1985). A clinographic projection of the unit cell is shown in Fig. 1. The coordination sphere around Er (site symmetry $m2m$) consists of 20 atoms if bonding interactions are considered for distances $< 4.0 \text{ \AA}$, resulting in a polyhedron with 20 apices [$\text{ErSi}_4\text{Ni}_4\text{Si}_6\text{Er}_6$] (Fig. 2a). The coordination polyhedron around the nickel atom (site symmetry $m2m$) is a tetragonal antiprism [NiSi_5Er_4] if bonding interactions are considered for distances $< 3.1 \text{ \AA}$. The antiprism is made up of 4 Er atoms in one basal plane with an additional Si atom, and 4 Si atoms in the second basal plane (Fig. 2b). The coordination polyhedra around the Si atoms (site symmetry $m2m$) are trigonal prisms (bonding interactions $< 3.1 \text{ \AA}$): tricapped [$\text{Si1Ni}_2\text{Si}_5\text{Er}_2$] with one additional Si and two Ni as the capping atoms (Fig. 2c), monocapped [$\text{Si2NiSi}_2\text{Er}_4$] with one additional Ni as the capping atom (Fig. 2d), and tricapped [$\text{Si3Ni}_2\text{Si}_5\text{Er}_2$] with one additional Si and two Er as the capping atoms (Fig. 2e). The interatomic distances are in good agreement with the sums of the atomic radii (Pauling, 1967). The shortest distance (Table 1) is observed between atoms Ni and Si2 (93% of the sum of the atomic radii of the corresponding atoms).

Experimental

The single crystal used in this work was extracted from an alloy with nominal composition $\text{Er}_{10}\text{Ni}_{25}\text{Si}_{65}$, which was prepared by arc melting of the initial components (purity better than 99.9%) in an electric arc furnace with a water-cooled copper bottom (Ti-getter) under an argon atmosphere and annealed at 870 K. A preliminary crystal investigation was performed using Laue and rotation methods (RKV-86 and RGENS-2 chambers, Mo $K\alpha$ radiation).

Crystal data

ErNiSi_3
 $M_r = 310.24$
 Orthorhombic, $Cmmm$
 $a = 3.9152 (5) \text{ \AA}$
 $b = 20.948 (3) \text{ \AA}$
 $c = 3.9313 (6) \text{ \AA}$
 $V = 322.42 (8) \text{ \AA}^3$
 $Z = 4$
 $D_x = 6.391 \text{ Mg m}^{-3}$

Mo $K\alpha$ radiation
 Cell parameters from 1395 reflections
 $\theta = 5.2\text{--}32.7^\circ$
 $\mu = 32.50 \text{ mm}^{-1}$
 $T = 295 (2) \text{ K}$
 Prism, metallic light grey
 $0.07 \times 0.05 \times 0.04 \text{ mm}$

Data collection

Oxford Diffraction Xcalibur3 CCD diffractometer
 ω scans
 Absorption correction: analytical
 CrysAlis RED (Oxford Diffraction, 2005)
 $T_{\min} = 0.187$, $T_{\max} = 0.274$
 1407 measured reflections

360 independent reflections
 358 reflections with $I > 2\sigma(I)$
 $R_{\text{int}} = 0.028$
 $\theta_{\max} = 32.7^\circ$
 $h = -5 \rightarrow 5$
 $k = -30 \rightarrow 30$
 $l = -3 \rightarrow 5$

Refinement

Refinement on F^2
 $R[F^2 > 2\sigma(F^2)] = 0.016$
 $wR(F^2) = 0.040$
 $S = 1.02$
 360 reflections
 22 parameters

$w = 1/[\sigma^2(F_o^2) + (0.0156P)^2 + 8.1601P]$
 where $P = (F_o^2 + 2F_c^2)/3$
 $(\Delta/\sigma)_{\max} = 0.001$
 $\Delta\rho_{\max} = 1.37 \text{ e \AA}^{-3}$
 $\Delta\rho_{\min} = -1.37 \text{ e \AA}^{-3}$
 Extinction correction: *SHELXL97*
 Extinction coefficient: 0.0108 (5)

Table 1

Selected interatomic distances (\AA).

Er–Si2 ⁱ	2.9586 (7)	Ni–Si2	2.247 (2)
Er–Ni ⁱⁱ	3.0300 (4)	Ni–Si3 ⁱ	2.2671 (11)
Er–Si1 ⁱⁱⁱ	3.0707 (15)	Ni–Si1 ^{vi}	2.2759 (11)
Er–Si3	3.0729 (15)	Si1–Si1 ^{vii}	2.340 (4)
Er–Si2	3.0823 (15)	Si1–Si3 ⁱⁱⁱ	2.7742 (3)
Er–Er ⁱⁱⁱⁱ	3.9152 (5)	Si2–Si2 ^{viii}	2.376 (2)
Er–Er ^v	3.9254 (6)	Si3–Si3 ^{ix}	2.347 (4)
Er–Er ^v	3.9313 (6)		

Symmetry codes: (i) $-x - \frac{1}{2}, -y + \frac{1}{2}, -z$; (ii) $-x + \frac{1}{2}, -y + \frac{1}{2}, -z + 1$; (iii) $x + 1, y, z$; (iv) $-x - \frac{1}{2}, -y + \frac{1}{2}, -z + 1$; (v) $x, y, z + 1$; (vi) $x, y, z - 1$; (vii) $-x, -y, -z + 1$; (viii) $-x + \frac{1}{2}, -y + \frac{1}{2}, -z$; (ix) $-x, -y + 1, -z$.

The structure refinement of ErNiSi_3 clearly indicates that this phase crystallizes in space group $Cmmm$, adopting the SmNiGe_3 structure type. Refinement in space group $Amm2$ (ScNiSi_3 structure type) was less satisfactory and resulted in higher R factors and atomic displacement parameters. The highest maximum residual electron density is located at a distance of 0.68 \AA from the Er atom, and the deepest hole is 1.99 \AA from the same atom.

Data collection: *CrysAlis CCD* (Oxford Diffraction, 2004); cell refinement: *CrysAlis CCD*; data reduction: *CrysAlis RED* (Oxford Diffraction, 2005); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *DIAMOND* (Brandenburg,

1999); software used to prepare material for publication: *SHELXL97* (Sheldrick, 1997).

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